

Enhancement Mode N-Channel Power MOSFET

 $TO-263/NMOS/30V/\pm20V/1.7V/150A/2.9m\Omega$

Rev_{0.2}





30V, 2.9mΩ, 150A, N-Channel MOSFET

1.Features

- ◆ Advanced Trench Technology
- ◆ Excellent R_{DS(ON)} and Low Gate Charge
- ◆ Lead Free

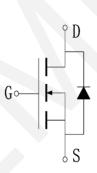
V_{DS}	$R_{DS(on)}$ Typ.	I _D Max.	
30V	2.9mΩ @ 10V	150A	
	5.0mΩ @ 4,5V		

2.Applications

- Load Switch
- ◆ PWM Application
- Power Management



TO-263 Pin Description



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP30150KF	WP30150	TO-263	800	4,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	30	V
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	I _D	150	А
Drain Current (Pulse), PW≤300µs	I _{DP}	600	А
Total Dissipation	P _D	347	W
Avalanche Energy, Single Pulsed	E _{AS}	210	mJ
Junction Temperature	T _j	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to Ambient	$R_{ hetaJA}$	30	°C/W
Junction to case	R _{eJC}	0.36	°C/W

Note 2: When mounted on 1 inch square copper board t ≤ 10sec The value in any given application depends on the user's specific board design.

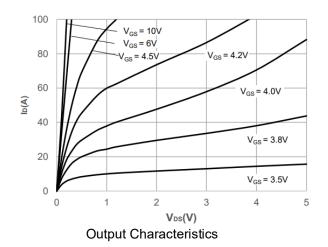
6.Electrical Characteristics at Ta=25°C (Note 3)

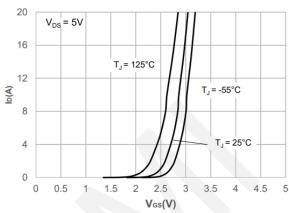
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
Zero-Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30V, V_{GS} = 0V$			1	μA
Gate to Source Leakage Current	I _{GSS1}	$V_{GS} = \pm 20V, V_{SS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	1.0	1.7	2.5	V
Static Drain to Source On-State	Б	I _D =50A, V _{GS} = 10V	-	2.9	3.5	mΩ
Resistance	R _{DS(on)}	$I_D = 30A, V_{GS} = 4.5V$	1	5.0	6.0	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		3650		pF
Output Capacitance	C _{oss}	V _{DS} =15V,		494		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		366		pF
Turn-on Delay Time	t _{d(on)}			10		ns
Rise Time	t _r	$V_{DD} = 15V, I_{D} = 30A$		19		ns
Turn-off Delay Time	$t_{d(off)}$	$V_{GS} = 10V,$ $R_{GEN} = 3\Omega,$		50		ns
Fall Time	t _f			20		ns
	Q_g	V_{DD} = 30V, V_{GS} = 0 to 10V, I_{D} = 15A		67		nC
Total Gate Charge	Q_{gs}			11		nC
	Q_{gd}			19		nC
Diode Forward Voltage	V_{FSD}	I _S = 50A, V _{GS} = 0			1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

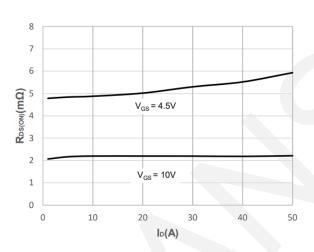


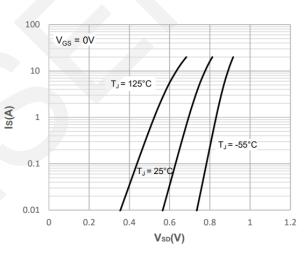
7. Typical electrical and thermal characteristics



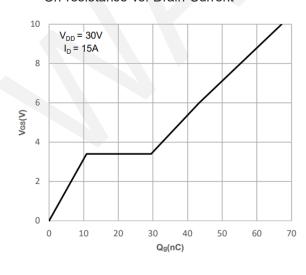


Typical Transfer Characteristics

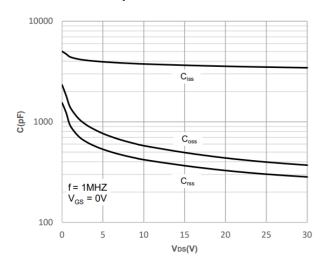




On-resistance vs. Drain Current



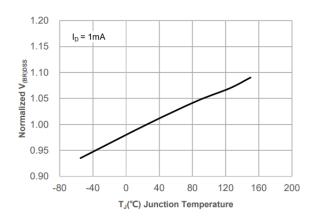
Body Diode Characteristics

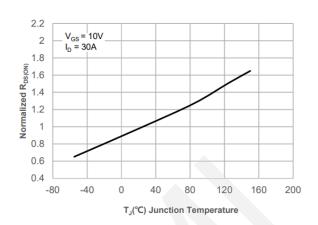


Gate Charge Characteristics

Capacitance Characteristics

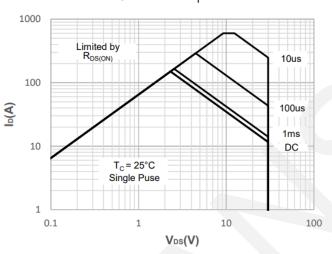






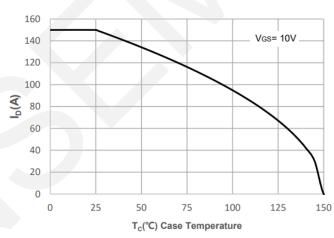
Normalized Breakdown Voltage vs.

Junction Temperature



Normalized on Resistance vs.

Junction Temperature



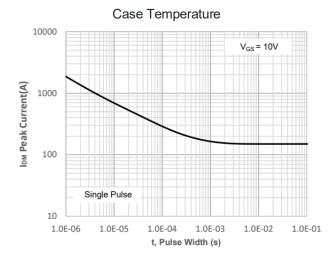
Maximum Safe Operating Area

10
D=0.5;
0.2
0.1
0.005.
0.001
0.001
sindle pulse

Duty factor: D = t1/12
Peak T,= Tc+Pow x Zeic x Rec

0.001
1.0E-06
1.0E-05
1.0E-04
1.0E-03
1.0E-02
1.0E-01
t, Pulse Width (s)

Maximum Continuous Drain Current vs.

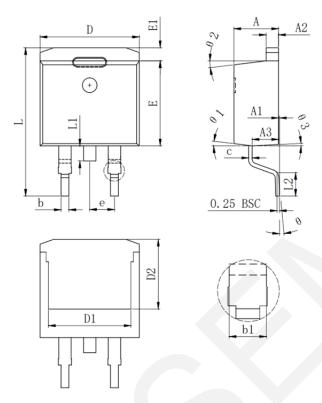


Normalized Maximum Transient Thermal Impedance

Peak Current Capacity



8.Package Dimensions



SYMBOL		MILLIMETER		
SIMDUL	MIN	Typ.	MAX	
A	4. 370	4. 570	4. 770	
A1	0.000		0. 250	
A2	1. 220	1. 270	1. 420	
A3	2. 490	2.690	2.890	
b	0. 700	0.810	0.960	
b1	1.170	1. 270	1. 470	
С	0.300	0.380	0.530	
D	9.860	10.160	10. 360	
D1	8. 400 REF			
D2	7.073 REF			
Е	8. 500	8. 700	8. 900	
E1	1.070	1. 270	1. 470	
e	2. 540 TYP			
L	14. 700	15. 100	15. 500	
L1	1. 400	1.550	1.700	
L2	2.000	2.300	2.600	
θ	0°		9°	
θ1	7° TYP			
θ2	7° TYP			
θ 3	3° TYP			



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